

<b>Notice of References Cited</b>	Application/Control No. 10/717,131		Applicant(s)/Patent Under Reexamination ONISHI ET AL.	
	Examiner Ives Wu		Art Unit 1724	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-3,847,728	11-1974	Hirata et al.	428/518
	C	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

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*	N	EP 1043361 A1	11-2000	Japan	Onishi et al	C08L 29/04
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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
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